PCOS 2014 TECHNICAL PROGRAM

December 4 (Thursday), 2014

13:00 - 13:10 **Opening Remarks**

13:10 - 13:20 Memorial address to Dr. Masahiro Okuda

Session 1

13:20 -14:00 (Invited)

I01. The structures and properties of Te nanoparticles

H. Ikemoto

Department of Physics, University of Toyama

14:00 - 14:40 (Invited)

I02. Frozen static heterogeneity and relaxation phenomena in metallic glasses

Tetsu Ichitsubo and Eiichiro Matsubara

Department of Materials Science and Engineering, Kyoto University

14:40 - 15:00 **Coffee Break**

Session 2

15:00 - 15:40 (Invited)

I03. A Consideration of (S,Se)-based and Te-based Chalcogenide Phase Change Phenomena for the Future Mass Memories Technologies for Achieving Higher Recording Capacity

Sakae Zembutsu

Graduate School of Informatics and Engineering, Career Education Division, The University of Electro-Communications

15:40 - 16:20 (Invited)

104. Cognitive Computing Systems and Neuromorphic Chips

Akihiro Horibe

IBM Research - Tokyo

16:20-16:45

S21. Mach-Zehnder Interferometer Type Optical Switch Using Phase-Change Material

Hiroyuki Tsuda¹, Takumi Moriyama¹, Yasuro Shimazaki¹, Masashi Kuwahara²,

Xiaomin Wang², and Hitoshi Kawashima²

¹ Graduate School of Science and Technology, Keio University

² National Institute of Advanced Industrial Science and Technology

Poster Session 16:45 – 18:15

Reception 19:00 – 21:00

Session 3

9:00 - 9:40 (Invited)

I05. Trial for Thermodynamic Calculation of Nano-particle Binary Alloy Phase Diagrams Toshihiro Tanaka

Division of Materials and Manufacturing Science, Graduate School of Engineering, Osaka University

9:40 - 10:05

S31. Pulsed light heating thermoreflectance technique for measuring thermophysical properties of interfacial phase-change thin film

T. Yagi¹, R. E. Simpson², P. Fons³, A. V. Kolobov³ and J. Tominaga³

¹National Metrology Institute of Japan, AIST

²Singapore University of Technology and Design

³Nanoelectronics Research Institute, AIST

10:05-10:30

S32. Thermal Conductivity of Ge₂Sb₂Te₅ at High Temperature

Rui Lan¹, <u>Rie Endo²</u>, Masashi Kuwahara³, Yoshinao Kobayashi², Masahiro Susa²
¹School of Material Science and Technology, Jiangsu University of Science and Technology
²Dept. of Metallurgy and Ceramics Science, Tokyo Institute of Technology
³Photonics Research Institute, National Institutes of Advanced Industrial Science and Technology

10:30 - 10:50 Coffee Break

Session 4

10:50-11:15

S41. Ultrafast Dynamics of Phase-Change Materials Observed Using Echelon-Based Single-Shot Setups

Ikufumi Katayama¹, Wataru Oba¹, Yasuo Minami¹, Toshiharu Saiki² and Jun Takeda¹

¹Graduate School of Engineering, Yokohama National University

²Graduate School of Science and Technology, Keio University

11:15-11:40

S42. Structural dynamics in Ge2Sb2Te5 upon ultra-short laser excitation by time-resolved x-ray diffraction using a free-electron laser

<u>Kirill Mitrofanov</u>¹, Paul Fons¹, Kotaro Makino¹, Ryo Terashima², Alexander V. Kolobov¹, Junji Tominaga¹, Alessandro Giussani³, Raffella Calarco³, Henning Riechert³, Takahiro Sato⁴,

Tetsuo Katayama⁵, Kanade Ogawa⁴, Tadashi Togashi⁵, Makina Yabashi⁴ and Muneaki Hase^{1,2}

¹Nanoelectronics Research Institute, AIST

²Institute of Applied Physics, University of Tsukuba

³Paul-Drude-Institut fur Festkorperelektronik

⁴RIKEN SPring-8, XFEL Research and Development Division

⁵XFEL Project Head Office, Japan Synchrotron Radiation Research Institute

11:40 - 13:00 **Photo and Lunch**

Session 5

13:00 - 13:40 (Invited)

I06. Magneto-optical Kerr effect of [(GeTe)₂(Sb₂Te₃)₁]_n superlattice without any magnetic

elements

H. Awano¹, D. Bang¹, J. Tominaga², A. Kolobov², P. Fons², Y. Saito², K. Makino², T. Nakano²,

M. Hase³, Y. Takagaki⁴, A. Giussani⁴, R. Calarco⁴, and S. Murakami⁵

¹Information Storage Materials Laboratory, Toyota Technological Institute

²Nanoelectronics Research Institute, National Institute of Advanced Industrial Science & Technology (AIST)

³Faculty of Pure and Applied Sciences, University of Tsukuba

⁴Paul-Drude-Institut für Festkörperelektronik

⁵Department of Physics, Tokyo Institute of Technology

13:40 - 14:05

S51. Electronic structure and deposition behavior of superlattice chalcogenide films

<u>Yuta Saito</u>, Junji Tominaga, Kotaro Makino, Xiaomin Wang, Alexander V. Kolobov, Paul Fons, and Takashi Nakano

National Institute of Advanced Industrial Science and Technology (AIST)

14:05 - 14:30

S52. Proposal on Hypothesis for Ultra-low Power Switching in Superlattice Phase Change Memories

Toshimichi Shintani^{1,2}, Susumu Soeya¹ and Toshiharu Saiki² ¹Institute of Advanced Industrial Science and Technology ²Keio University

14:30 - 14:50 Coffee Break

Session 6

14:50-15:30

I07. To be announced (Speaker: E. Matsubara)

15:30 - 15:55

S61. A study on phase change characteristics of $(GeTe)_{1-x}Si_x$ films

Y. Sutou¹, Y. Saito², and J. Koike¹

¹Department of Materials Science, Graduate School of Engineering, Tohoku University

²Nanoelectronics Research Institute, AIST

15:55 - 16:20

S62. Computing based on coupled plasmon particles with phase change material

Takashi Hira, Kenta Kuwamura, Yuya Kihara, Tasuku Yawatari, Yusuke Hirukawa, Shohei Kanazawa, and <u>Toshiharu Saiki</u>

Graduate School of Science and Technology, Keio University

16:20 – 16:30 Best Paper Awarding

16:30 – 16:40 Closing Remarks (Memorial address to Dr. Tatsuo Kinoshita)

Poster Session

P01. Contact resistivity of GeCu2Te3 on metal electrode measured by CTLM

Satoshi Shindo¹, Yuji Sutou¹, Junichi Koike¹, and Yuta Saito²

¹Dept. of Materials Science, Tohoku University

²Nanoelectronics Research Institute, AIST

P02. Ultrafast Amorphization of GeTe Induced by Femtosecond Laser Pulses

Wataru Oba¹, Ikufumi Katayama¹, Yasuo Minami¹, Toshiharu Saiki² and Jun Takeda¹ ¹Graduate School of Engineering, Yokohama National University ²Graduate School of Science and Technology, Keio University

P03. Phase Error Compensation of Si Waveguide Using Phase-Change Material

Ryutaro Eguchi, Yasuro Shimazaki, and Hiroyuki Tsuda Graduate School of Science and Technology, Keio University

First principles calculation study of electronic and optical properties of liquid InSb P04.

H. Sano¹ and G. Mizutani²

¹Department of General Education, Ishikawa National College of Technology ²School of Materials Science, Japan Advanced Institute of Science and Technology

P05. Fitting Model for Electric Conduction of Amorphous GeSbTe in Wide Field Range

Toshimichi Shintani, Yumiko Anzai, and Hiroyuki Minemura Central Research Laboratory, Hitachi, Ltd.

P06. Emission energy control of semiconductor quantum dots using phase change mask and its applications

Yu Sato, Shohei Kanazawa, Ariyoshi Yamamura, and Toshiharu Saiki Graduate School of Science and Technology, Keio University

P07. Mechanism of the crystal/amorphous phase periodic structure formation by pulsed laser irradiation

Takanori Morita, Yusuke Morimoto, Ryota Akimoto and Toshiharu Saiki Graduate School of Science and Technology, Keio University

Spectroscopic study of localized surface plasmon resonance switching of single Au P08. nanoparticles induced by phase change of GeSbTe

Yuya Kihara, Takashi Hira, Kenta Kuwamura, and Toshiharu Saiki Department of Electronics and Electrical Engineering, Keio University

P09. Solving spin glass problems using coupled plasmon particles with phase change material

Shohei Kanazawa, Y. hirukawa, and Toshiharu Saiki

Graduate School of Science and Technology, Keio University